

**Notice of References Cited**

Application/Control No.

09/501,944

Applicant(s)/Patent Under  
Reexamination  
VENKATESAN ET AL.

Examiner

Julian A. Mercado

Art Unit

1745

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
	C	US-			
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	J	US-			
	K	US-			
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**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	9-120817	05-1997	Japan	Hayashi et al.	H01M 004/62
	O					
	P					
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